



ΕΛΛΗΝΙΚΗ ΔΗΜΟΚΡΑΤΙΑ
ΥΠΟΥΡΓΕΙΟ ΠΑΙΔΕΙΑΣ
ΔΙΑ ΒΙΟΥ ΜΑΘΗΣΗΣ ΚΑΙ ΘΡΗΣΚΕΥΜΑΤΩΝ

ΙΔΡΥΜΑ ΚΡΑΤΙΚΩΝ ΥΠΟΤΡΟΦΙΩΝ
(Ι.Κ.Υ.)
ΔΙΕΥΘΥΝΣΗ ΕΙΔΙΚΩΝ ΠΡΟΓΡΑΜΜΑΤΩΝ
ΔΙΕΘΝΩΝ ΥΠΟΤΡΟΦΙΩΝ
ΤΜΗΜΑ ΠΡΟΓΡΑΜΜΑΤΩΝ ΕΥΡΩΠΑΪΚΗΣ
ΕΝΩΣΗΣ



Εκπαίδευση και Πολιτισμός
Πρόγραμμα Δια Βίου Μάθησης
ERASMUS- Εντατικά Προγράμματα

• ANNEX II: TENTATIVE SUMMARY OF CPO COURSE

Introduction to Charged Particle Optics: Theory and Simulation

Tentative Course Summary

1. TRANSPORT OF CHARGED PARTICLE BEAMS (UCM, AKU, UoC, UoI)

- Charged Particle Motion in Electromagnetic Fields (UCM)
- Gaussian Optics and Transfer Matrices (UCM)
- Charged Particle Beams and Phase Space (UCM,UoC)
- Aberrations in CPO (UCM, AKU, UoC)
- Numerical Methods (FDM,BEM,FEM) for solving Laplace Equation (UCM)
- Numerical Methods for the calculation of charged particles trajectories (UCM)
- Introduction to SIMION 8.0 (AKU, UoC, UoI)

2. ELECTROSTATIC LENSES (AKU, UCM, UoC)

- General properties (AKU, UCM, UoC)
- Two-cylinder Lenses (AKU, UCM, UoC)
- Three-cylinder Lenses (AKU, UCM, UoC)
- Four- and Five-cylinder Lens (AKU, UCM, UoC)

3. ENERGY DISPERSIVE DEVICES (UoC, AKU, UoI, UCM)

- General properties (UoC)
- Parallel plate Analyzers (UoC)
- Hemispherical Deflector Analyzers (UoC, AKU, UoI, UCM)
- Cylindrical Zoom Lenses and Hemispherical Deflector Analyzers (UoC, AKU, UoI, UCM)
- Two-stage analyzers (UoC)



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4. TIME OF FLIGHT DEVICES (SU, UoI, UoC, AKU, TUW)

- General properties (SU,AKU, UoI,UoC)
- Space Focusing (SU, AKU)
- Time Focusing (SU, AKU,TUW)

5. IMAGING DEVICES (UoI, UoC, SU, TUW)

- General properties (UoI,UoC)
- Motion in Static Electric Fields (UoI,UoC)
- Motion in Static Electric and Magnetic Fields (UoC,UoI)
- Velocity Mapping and Slice Imaging (UoC,UoI,SU)

Recommended course books:

- M. Yavor, [Optics of Charged Particle Analyzers](#), Advances in Imaging and Electron Physics, Edited by P. Hawkes (Elsevier, 2009), vol. 157, chapters 1-3, 5, 7,8.
- S. Humphries Jr., [Principles of Charged Particle Acceleration](#), (John Wiley & Sons, 1999) chapters 1-9.
- S. Humphries Jr., [Charged Particle Beams](#), (John Wiley & Sons, 2002) chapters 1-3.
- [SIMION Version 8.0](#), User Manual (Scientific Instrument Services Inc., Ringoes NJ, 2006)
- D W O Heddle, *Electrostatic Lens Systems* (IoP, 2nd edition, 2000)
- John Moore, Christopher C. Davis, Michael A. Coplan, Sandra Greer, [Building Scientific Apparatus](#) (Cambridge University Press; 4th edition, 2009)

Older references:

- H. Wollnik, *Optics of Charged Particles* (Academic Press, 1987)
- David A. De Wolf, *Basics of electron Optics* (John Wiley, 1990)
- Poul Dahl, *Introduction to Electron and Ion Optics* (Academic Press, 1973)

Other Interesting links:

- [Cutting edge Numerical tools for your PC](#)
- [Charged particle Optics programs](#)